

Vishay Siliconix

RoHS

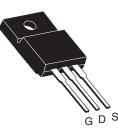
COMPLIANT

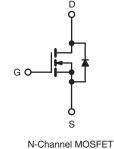


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	400			
R _{DS(on)} (Ω)	V _{GS} = 10 V	1.0		
Q _g (Max.) (nC)	38			
Q _{gs} (nC)	5.7			
Q _{gd} (nC)	22			
Configuration	Single			

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI730GPbF
	SiHFI730G-E3
SnPb	IRFI730G
	SiHFI730G

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherv	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	400	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V T _C	T _C = 25 °C	- I _D	3.7		
		$T_C = 100 ^{\circ}C$		2.3	A	
Pulsed Drain Current ^a			I _{DM}	15	1	
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	200	mJ	
Repetitive Avalanche Current ^a			I _{AR}	I _{AR} 3.7		
Repetitive Avalanche Energy ^a			E _{AR} 3.5		mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	35	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 25 mH, $R_G = 25 \Omega$, $I_{AS} = 3.7$ A (see fig. 12).

c. $I_{SD} \le 3.7$ A, dI/dt ≤ 90 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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PARAMETER	SYMBOL	TYP. MAX.				UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 65				_				
Maximum Junction-to-Case (Drain)	R _{thJC}				- °C/W					
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted								
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT		
Static		•								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μA	400	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C,	I _D = 1 mA	-	0.54	-	V/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	2.0	-	4.0	V		
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20$	V	-	-	± 100	nA		
		V _{DS} =	= 400 V, V _G s	₆ = 0 V	-	-	25			
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 320 V	/, V _{GS} = 0 V	, T _J = 125 °C	-	-	250	- μΑ		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 2.1 A ^b	-	-	1.0	Ω		
Forward Transconductance	g _{fs}	V _{DS} =	= 50 V, I _D =	2.1 A ^b	3.6	-	-	S		
Dynamic						•	•			
Input Capacitance	C _{iss}	V _{GS} = 0 V,			-	700	-	pF		
Output Capacitance	C _{oss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	170	-				
Reverse Transfer Capacitance	C _{rss}			-	64	-				
Drain to Sink Capacitance	С		f = 1.0 MHz		-	12	-			
Total Gate Charge	Qg			-	-	38				
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		7 A, $V_{DS} = 320$ V,	-	-	5.7	nC		
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	-	22	1		
Turn-On Delay Time	t _{d(on)}				-	10	-			
Rise Time	t _r		=200 V, I _D =		-	15	-	1		
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 12 \Omega, R_{D} = 57 \Omega,$ see fig. 10 ^b		-	38	-	ns			
Fall Time	t _f		Ū		-	14	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-				
Internal Source Inductance	L _S			-	7.5	-	nH			
Drain-Source Body Diode Characteristic	s	•								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.7	A			
Pulsed Diode Forward Current ^a	I _{SM}			-	-	15				
Body Diode Voltage	V_{SD}	T _J = 25 °C	, I _S = 3.7 A,	$V_{GS} = 0 \ V^{b}$	-	-	1.6	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 3.7 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	260	530	ns			
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.2	μC			
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and I					_D)			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

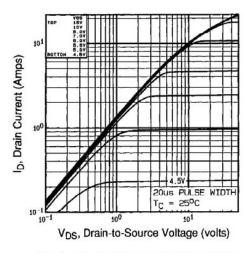


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

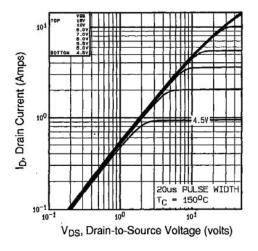


Fig. 2 - Typical Output Characteristics, $T_C = 150 \ ^{\circ}C$

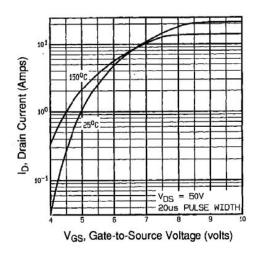


Fig. 3 - Typical Transfer Characteristics

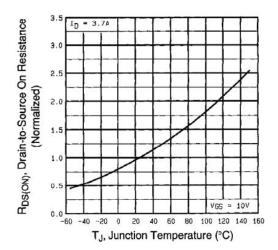


Fig. 4 - Normalized On-Resistance vs. Temperature

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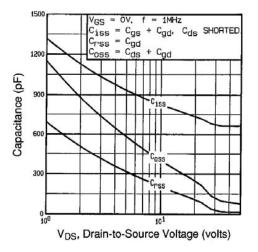


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

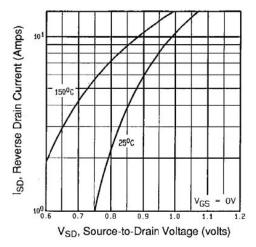


Fig. 7 - Typical Source-Drain Diode Forward Voltage

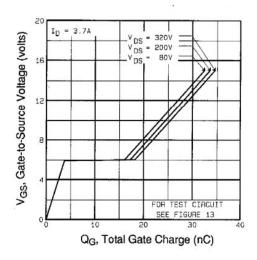


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

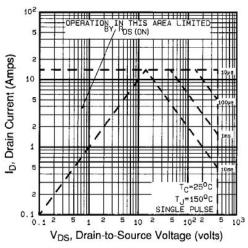


Fig. 8 - Maximum Safe Operating Area



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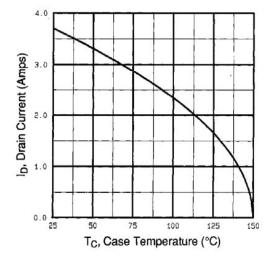


Fig. 9 - Maximum Drain Current vs. Case Temperature

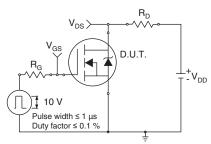


Fig. 10a - Switching Time Test Circuit

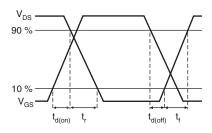
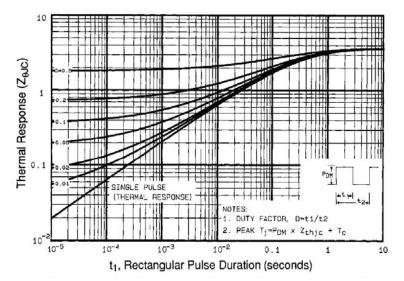
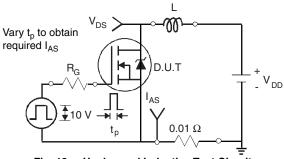


Fig. 10b - Switching Time Waveforms









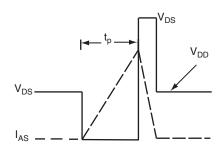


Fig. 12b - Unclamped Inductive Waveforms

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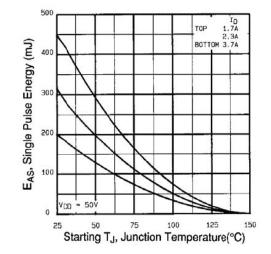


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

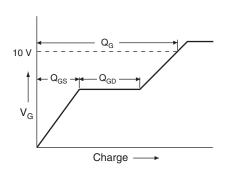
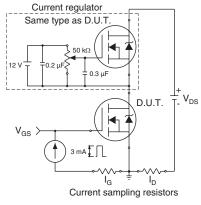
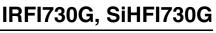


Fig. 13a - Basic Gate Charge Waveform

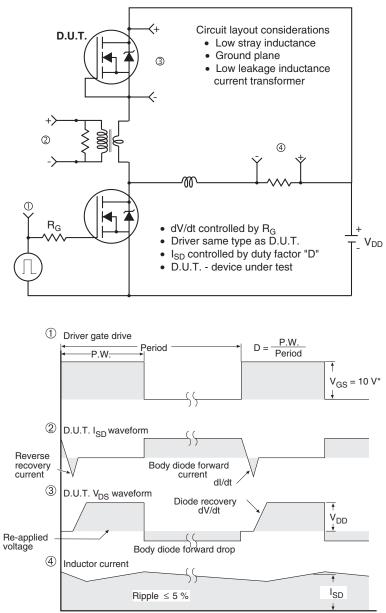






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Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig.14 - For N-Channel

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